

UNITED STATES DEPARTMENT OF COMMERCE National Institute of Standards and Technology Gaithersburg, Maryland 20899-0001

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Subject: Letter of Appreciation for Collaboration and Technical Excellence

The United States Department of Commerce, National Institute of Standards and Technology (NIST) Computer Security Division extends its appreciation and thanks for the shared contributions of the individuals listed below.

Their collaboration, technical excellence and dedication have made significant contributions to NIST and advanced the science of conformance testing and vulnerability analysis. Specifically, the contributions to Non-Invasive Attack sections of the FIPS 140-3 draft and the very first draft of ISO/IEC 17825 were significant in advancing the state of art in cryptographic module testing.

The development of experimental circuit boards, design of LSI circuits, conducting experiments and analyses, and generating draft material contributed to the international standards body was essential to the Division and the Cryptographic

Module Validation Program.

The Point of Contact for this memorandum is the undersigned.

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